

High temperature impedance spectroscopy of barium stannate, BaSnO₃

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Abstract. Polycrystalline powder of BaSnO₃ was prepared at 1300 °C using a high-temperature solid-state reaction technique. X-ray diffraction analysis indicated the formation of a single-phase cubic structure with lattice parameter: $a = (4.1158 \pm 0.0003) \text{ \AA}$. The synthesized powder was characterized using X-ray diffraction (XRD) scanning electron micrographs, energy dispersive X-ray analysis, differential thermal analysis, thermogravimetric analysis and Fourier transform infrared techniques. Electrical properties were studied using a.c. impedance spectroscopy technique in the temperature range of 50–650 °C and frequency range of 10 Hz–13 MHz. The complex impedance plots at temperature $\geq 300 \text{ }^\circ\text{C}$ show that total impedance is due to the contributions of grains, grain boundaries and electrode. Resistance of these contributions has been determined. Variation of these resistances with temperature shows the presence of two different regions with different slopes. The nature of variation for the above three resistances, in both the temperature regions confirms that conducting species (phases) responsible for grain, grain boundaries and electrode are the same. Based on the value of activation energy, it is proposed that conduction via hopping of doubly ionized oxygen vacancies ($V_o^{2\bullet}$) is taking place in the temperature region of 300–450 °C, whereas in the temperature region of 450–650 °C, hopping of proton, i.e. OH[•] ions occurs.

Keywords. Ceramics; oxides; infrared spectroscopy; electrical properties; electrical conductivity.

1. Introduction

Alkaline earth stannates have the general formula, MSnO₃ (M = Ba, Sr, Ca and Pb). These oxides are structurally analogous to the naturally occurring mineral perovskite, CaTiO₃. Barium stannate (BaSnO₃) is a cubic perovskite oxide compound which behaves as an n -type semiconductor with a wide bandgap of 3.4 eV. It is thermally stable up to 2000 °C (Shimizu *et al* 1985; Larramona *et al* 1989; Cava *et al* 1990; Smit *et al* 1992). Pure and doped barium stannates have found important applications in materials science and technology due to their dielectric properties, semiconducting behaviour and high thermal stability. Owing to these characteristics properties, BaSnO₃-based ceramics are becoming more and more important in materials technology. They can be used to prepare thermally stable capacitors and to fabricate ceramic boundary layer capacitors (Prokopale 1976; Vivekanandan and Kutty 1990; Wang *et al* 2003; Kumar *et al* 2005a). Moreover, barium stannate can also be used as a functional material for semiconductor gas and humidity sensor (Ostrick *et al* 1997; Tao *et al* 2000; Gopal Reddy *et al* 2001; Cerda *et al* 2002; Kocemba *et al* 2007; Upadhyay and Kavita 2007; Doroflet *et al* 2012) and photocatalytic applications (Borse *et al* 2007; Yuan *et al* 2007; Zhang *et al* 2008). Due to these noteworthy applications, considerable amount

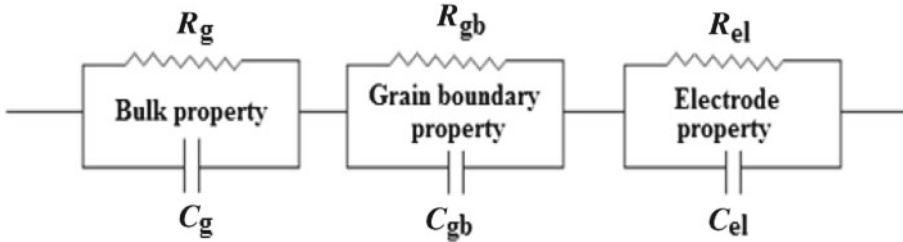
of research has been devoted to the study of synthesis of this material (Kutty and Vivekanandan 1987; Upadhyay *et al* 1997; Azad and Hon 1998; Pfaff *et al* 1998; Song and Kim 2001; Roberto *et al* 2006; Lu and Schmidt 2007, 2008; Wang *et al* 2007; Ramdas and Vijayraghavan 2010; Deepa *et al* 2011).

Literature survey indicates that electrical properties of BaSnO₃ have basically been studied by conventional (d.c.) methods (Smolensi *et al* 1955; Raevski *et al* 1983). A few reports are available on characterization of this material by impedance spectroscopy but only in the temperature range of 300–500 °C (Kumar *et al* 2005a, b, 2006a, b, 2007; Kumar and Choudhary 2007). BaSnO₃-based materials have recently been proposed as high temperature protonic conductors (Murugaraj *et al* 1997; Schober 1998; Bevillon *et al* 2008; Wang *et al* 2011) with potential applications in fuel cells. Electrical characterization by impedance method will be worthwhile for development of this material for fuel cell application. A systematic analysis of its electrical properties by a.c. technique of impedance analysis has, however, not been carried out at high temperatures (above 300 °C). The present paper reports our investigations on electrical properties of BaSnO₃. Impedance analysis approach has been used to separate the real and imaginary components of electrical response and estimate the electrical relaxation time (τ_{max}) at different temperatures. Impedance spectrum and electrical conductivity have been measured as a function of temperature (50–650 °C) and frequency (10 Hz–13 MHz).

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Complex plane impedance spectroscopy is considered to be a promising non-destructive testing method for analysing the electrical processes occurring in a compound on application of a.c. signal as input perturbation. The output response of polycrystalline compound represents grain, grain boundary and interfacial properties with different time constants. Using this technique, one can separate out resistance of grain interiors, grain boundaries and electrode. From

these data and knowledge of the sample dimensions, the bulk (or grain interior) and grain boundaries conductivities can be estimated in rather straightforward manner. The equivalent electrical circuit shown below is widely used to fit impedance data of polycrystalline materials. In this equivalent circuit, it is desired to separate each of the *Resistance–capacitance* (*RC*) components and measure values. This can be seen from the equation for the impedance of this circuit.



$$Z = Z' - jZ'' = \left(1/R_g + j\omega C_g\right)^{-1} + \left(1/R_{gb} + j\omega C_{gb}\right)^{-1} + \left(1/R_{el} + j\omega C_{el}\right)^{-1}, \quad (1)$$

$$Z' = \left[\frac{R_g}{1 + \omega^2 C_g^2 R_g^2} + \frac{R_{gb}}{1 + \omega^2 C_{gb}^2 R_{gb}^2} + \frac{R_{el}}{1 + \omega^2 C_{el}^2 R_{el}^2} \right], \quad (2)$$

$$Z'' = \left[\frac{(\omega R_g^2 C_g)}{1 + \omega^2 C_g^2 R_g^2} + \frac{(\omega R_{gb}^2 C_{gb})}{1 + \omega^2 C_{gb}^2 R_{gb}^2} + \frac{(\omega R_{el}^2 C_{el})}{1 + \omega^2 C_{el}^2 R_{el}^2} \right]. \quad (3)$$

Thus, complex plane impedance plots (Z'' vs Z') of many polycrystalline materials exhibit an arc at high frequency, a second arc at lower frequencies and a third arc at even lower frequencies. In complex plane impedance plot, ideal semicircle (whose centre lies on the Z' axis) appears only when contribution to this arc is having single relaxation time. If distribution of relaxation times exists, then one gets a depressed arc instead of an ideal semicircle. The frequency at the apex of each of the arcs corresponds to the characteristic frequency, ω_0 , of the respective (*RC*) subcircuit. The characteristic frequency, ω_0 , of a material or a region of a material is equal to $1/RC$. Since R and C depend on geometric parameters in an inverse manner, ω_0 is an intrinsic material property, independent of geometric consideration, and equal to $1/\rho\epsilon_0\epsilon_r$ (where ρ , resistivity = $1/\sigma$, ϵ_0 , permittivity of free space and ϵ_r , relative permittivity of material) (Burn and Neirman 1984; MacDonald and Johnson 1987; Haile *et al* 1998).

2. Experimental

Barium stannate was synthesized by solid state ceramic method. The starting compounds used for preparation of the sample were BaCO_3 (Merck, India, purity 99.0%) and SnO_2 (Aldrich-Sigma, USA, purity 99.9%). Stoichiometric amounts of these compounds were mixed in a ball mill for 6 h using acetone as the mixing media. The homogeneous mixture was heated in an alumina crucible up to 1000°C and held at this temperature for 8 h. Polyvinyl alcohol was added to the calcined powder for the fabrication of pellets, which was burnt out during high temperature sintering. Circular disc-shaped pellets were prepared by applying a uniaxial load of 5 ton. These pellets were subsequently sintered at 1250°C for 12 h. To improve homogeneity, sintered pellets were crushed, re-pelletized and re-sintered at 1300°C for 12 h.

A preliminary study on compound formation and structural parameter was carried out using X-ray diffraction (XRD) technique with an X-ray powder diffractometer (Rigaku Miniflex). XRD pattern of the calcined powder was recorded at room temperature with $\text{CuK}\alpha$ radiation (1.5418 \AA) in a wide range of Bragg's angles 2θ ($20^\circ \leq 2\theta \leq 80^\circ$) at a scan speed of $4^\circ/\text{min}$. For scanning electron micrographs (SEM) and energy dispersive X-ray analysis (EDXA), freshly fractured surfaces of the sintered pellets were gold-sputtered and scanned in different regions using a JEOL JSM-5800 scanning electron microscope. Thermal analysis (DTA and TGA curves) of the sample was made using a Perkin-Elmer (Model Pyrix EXST AR 6000) TG-DTA instrument in the temperature range of $30\text{--}850^\circ\text{C}$ with a heating rate of 10°C in nitrogen atmosphere. Fourier transform infrared (FTIR) spectra of the sample were recorded using Shimadzu (Model DF 803) Fourier transform infrared spectrometer in the wave number range of $400\text{--}4000 \text{ cm}^{-1}$.

For impedance measurements, polished surfaces of the pellets were coated with high purity air-drying silver paste.

These pellets were cured at 700 °C for 10 min. Impedance measurements were done using a computer-controlled impedance analyser (HP 4192 A LF) over a wide range of temperatures (50–650 °C) and frequencies (10 Hz–13 MHz).

3. Results and discussion

3.1 Structural analysis

XRD pattern of the powder sintered at 1250 °C is shown in figure 1(a). The figure shows that no new phase is formed

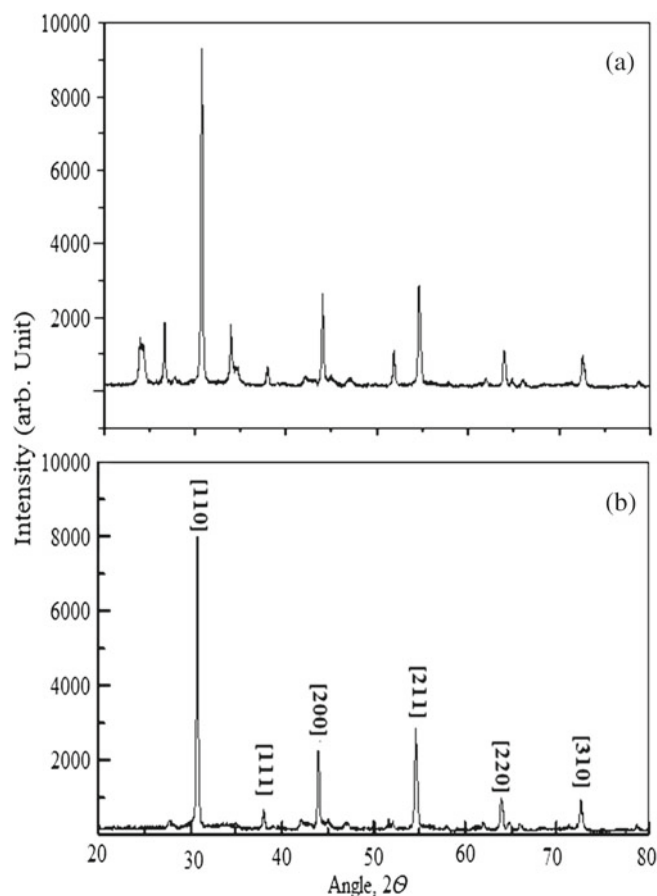


Figure 1. X-ray diffraction pattern of sample sintered at (a) 1250 °C and (b) 1300 °C of BaSnO₃.

in the powder except for small traces of BaCO₃ and SnO₂ which has been confirmed from the presence of low intensity peaks of these compounds. Figure 1(b) shows XRD pattern of powder sintered at 1300 °C. In this figure, all the peaks are assigned to cubic structure of BaSnO₃. XRD data of the sintered powder is given in table 1. Lattice parameter of the sample was calculated using a program known as CELL. Calculated lattice parameter is found to be 4.1158 ± 0.0003 Å and it agrees very well with the reported XRD data in the joint committee on powder diffraction standard (JCPDS) file (JCPDS card no. 15-0780) for BaSnO₃ which indicates complete formation of BaSnO₃. The crystallite size of the synthesized powder of BaSnO₃ was calculated using the Debye–Scherrer equation

$$D = 0.9\lambda / \beta \cos \theta_{\max},$$

where D is the crystallite size, λ the wavelength of CuK α radiation, β the line width at half peak intensity and θ_{\max} the diffraction peak angle. Crystallite size calculated for all planes is given in table 1. The average crystallite size was found to be 80 nm.

Bulk density (d_b) of the sample was obtained using Archimedes' principle. Theoretical density (d_{th}) of the sample was calculated from the molecular weight of the samples and its lattice parameter. Percentage porosity was calculated using the formula:

$$\% \text{ Porosity} = [(d_{th} - d_b) / (d_{th})] \times 100. \quad (4)$$

Bulk density, theoretical density and percentage porosity of the sample are 5.97 g/cm³, 7.24 g/cm³ and 18%, respectively.

3.2 Microstructural analysis

SEM surface morphology of the sample (of three randomly chosen regions A, B and C on the surface of the pellet) is shown in figure 2. It is observed that grain size of the sample is small (< 1 μm). Small grain size of the sample as compared to that reported in the literature is attributed to lower sintering temperature and time used for the synthesis (Smith and Welch 1960). Porous nature of the sample is also reflected in the SEM photographs. Similarity in

Table 1. XRD data of the synthesized BaSnO₃ powder.

Angle (2θ _{abs.})	$d_{abs.}$ values (Å)	$d_{ref.}$ values (Å)	Peak width at half intensity	Peak intensity	Reflection plane	Crystallite size (nm)
30.6716	2.91248	2.9109	0.1717	2754.3	110	54
37.8518	2.37488	2.3775	0.1685	61.97	111	60
43.9431	2.05877	2.0585	0.1602	871.77	200	69
54.5717	1.68026	1.6789	0.1821	1173.3	211	75
63.9309	1.45499	1.4554	0.1918	510.55	220	94
72.6007	1.30111	1.2999	0.2203	503.17	310	121

appearance of SEM of all the three regions (A, B and C) indicates homogeneous nature of the sample and uniform distribution of porosity. Compositional homogeneity (in terms of concentration profile of the elements) has been probed by recording EDXA spectra of different regions of the sample. EDX spectrum of regions A, B and C (corresponding to figure 2(a–c)) is shown in figure 3. Figure 3 shows the presence of Sn, Ba and O peaks only. Composition of these elements is recorded in table 2. Quantification calculation

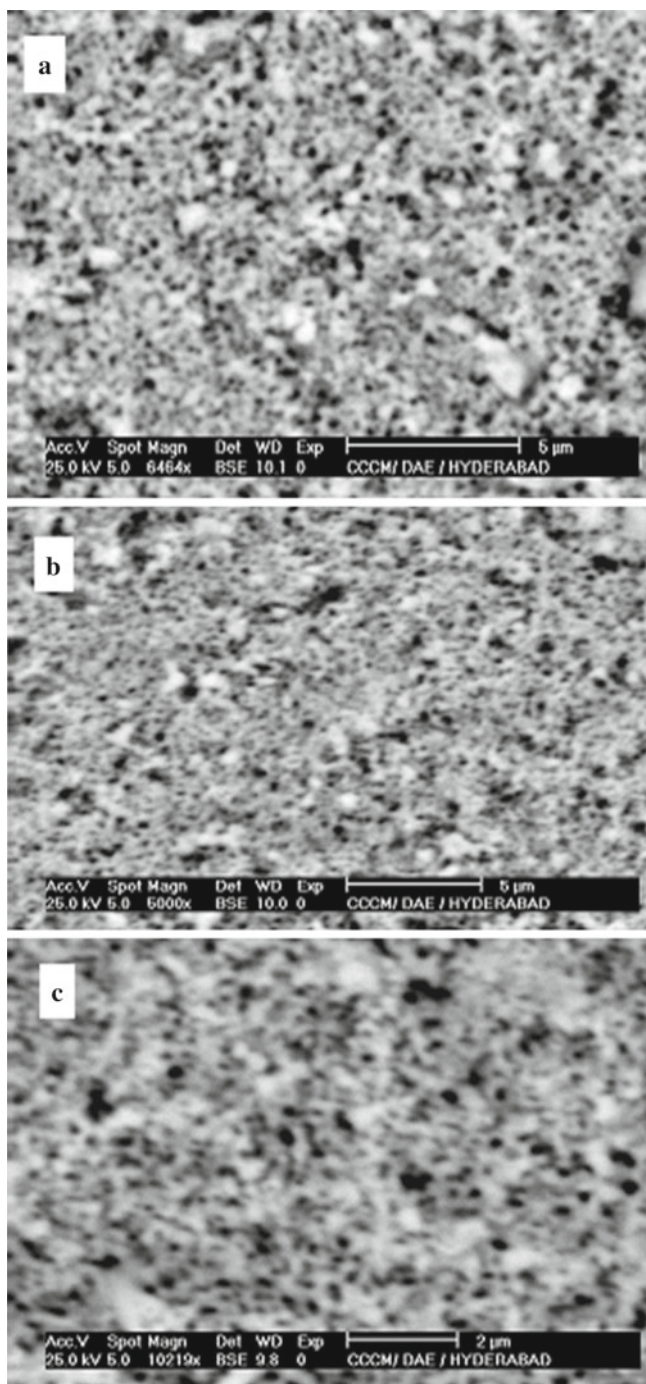


Figure 2. Scanning electron micrographs of randomly chosen three regions (a, b and c) of BaSnO₃.

shows that atomic ratio of Ba/Sn in all the three regions is approximately same (within the experimental error), which reflects the homogeneous nature of the synthesized powder.

3.3 Thermal analysis

Thermal characterization of the synthesized powder has been carried out using differential thermal analysis (DTA) and thermogravimetric analysis (TGA) up to 850 °C at a heating rate 10 °C/min in nitrogen atmosphere. DTA and TGA curves of the powder are shown in figure 4. TGA exhibits an 8% total weight loss in three steps, the first step from RT to 200 °C (with a loss of 3.6%), the second step from 200 to 550 °C (with a loss of 1.2%) and the third step from 550 to 850 °C (with a loss of 3.2%). Weight loss is mainly due to the removal of water adsorbed by the sample.

Enthalpy changes observed in the DTA curve at different temperatures can be attributed to surface reaction taking place in BaSnO₃. There is no evidence of any phase transition taking place in the sample up to this temperature.

3.4 FTIR spectroscopy

Oxygen–hydrogen groups can be identified by using FTIR spectroscopy. FTIR spectrum of the synthesized powder of

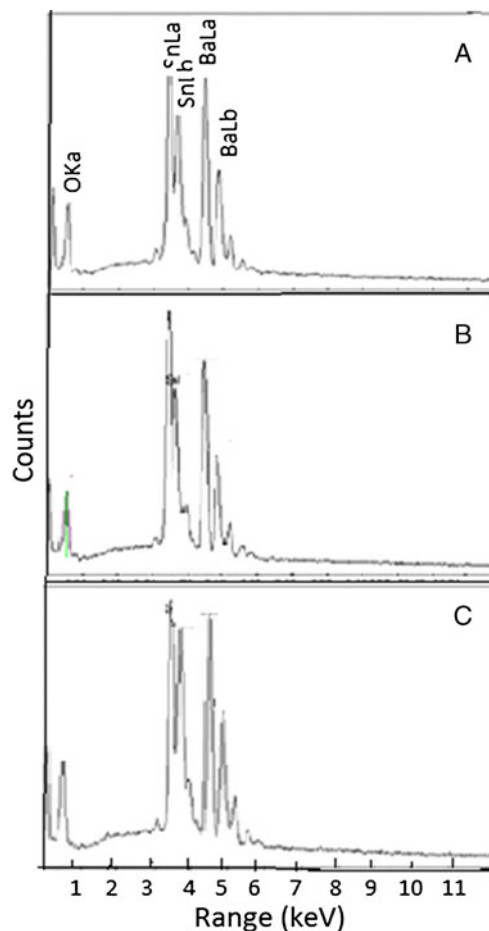
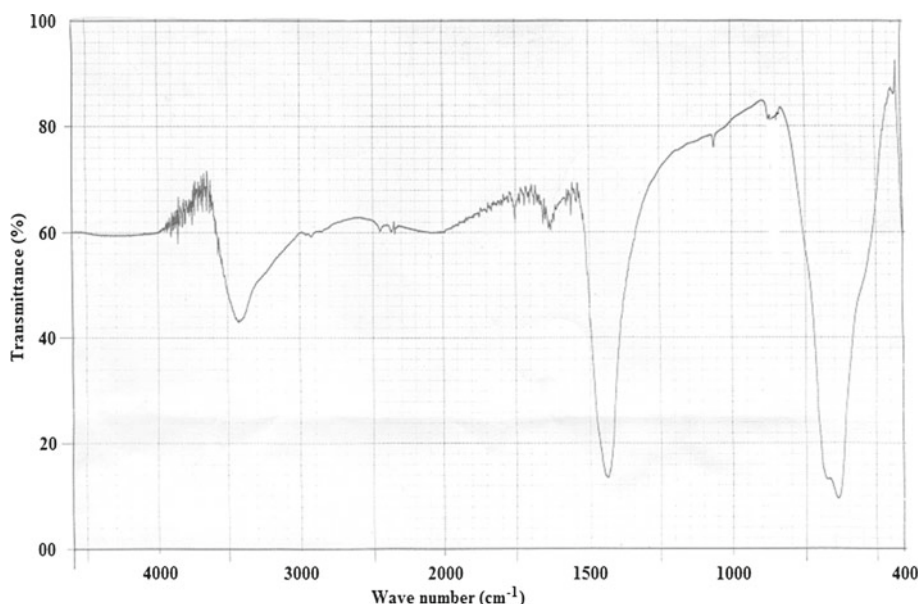


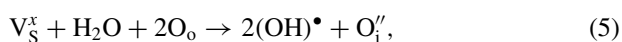
Figure 3. Energy dispersive X-ray spectra of BaSnO₃.

Table 2. Concentration profile of elements by energy dispersive (EDX) analysis in three randomly chosen grains.

Region	Elements	Atom %		Sn/Ba ratio
		Theoretical	Experimental	
A	Oxygen	60	62.93	1.009
	Sn	20	18.61	
	Ba	20	18.45	
	Total	100	100	
B	Oxygen	60	62.82	1.018
	Sn	20	18.76	
	Ba	20	18.42	
	Total	100	100	
C	Oxygen	60	63.13	1.014
	Sn	20	18.56	
	Ba	20	18.31	
	Total	100	100	

**Figure 4.** FTIR spectra of barium stannate, BaSnO₃.

BaSnO₃ is shown in figure 5. It is noticed that FTIR spectrum of this sample has mainly two extra peaks at 3450 and 1420 cm⁻¹ as compared to FTIR spectrum of BaSnO₃ reported in the literature (Gopal Reddy *et al* 2001). The peak at 3450 cm⁻¹ is assigned to the stretching modes of O–H bond and is related to water adsorbed at the surface of the sample. An intense band at 1420 cm⁻¹ can be assigned to M–OH group vibration (Animitsa *et al* 2011). Hence, the main part of the hydrogen atom is present in the form of hydroxide ions. Water insertion into the oxide structure can be represented as the process of the dissociative dissolution and formation of proton defects



where all the species are written in accordance with Kröger-Vink notation of defects.

3.5 Impedance analysis

Complex impedance plots at different temperatures (in the range 150–650 °C) of the sample are shown in figure 6. At 150 °C, a steep rising of Z'' (almost parallel to Z') is observed. Similar plots have been observed at temperatures 50 and 100 °C. As temperature increases to 200 °C, curve bends toward real axis, i.e. Z' axis and takes the shape of a semicircle. At 250 °C, two semicircular arcs have been observed, although the low frequency semicircle is incomplete due to lower limit of frequency of the impedance

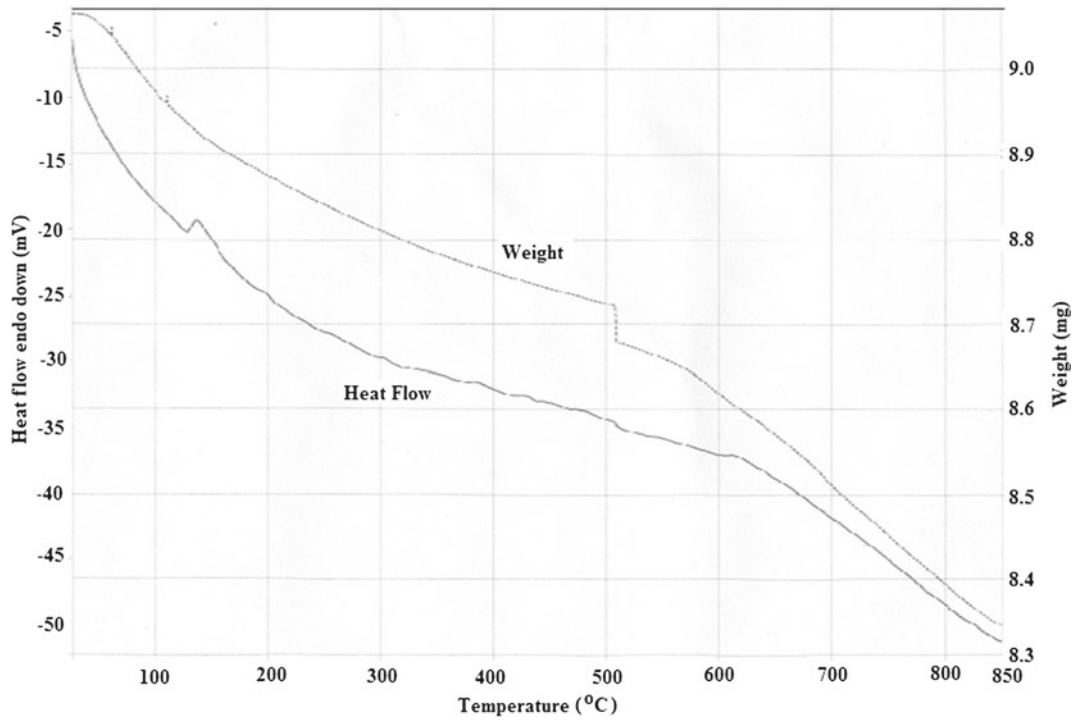


Figure 5. DTA-TGA curve for BaSnO₃ sample.

analyser used in the present study. Impedance spectra of the sample in the temperature range of 300–650 °C have three semicircular arcs. Frequency ranges of these arcs overlap. High frequency arcs at 300 and 350 °C pass through the origin, but the spectrum at 400 °C and above does not pass through the origin. An intercept of $\sim 400 \Omega$ is observed which remains almost constant up to the last temperature of measurement, i.e. up to 650 °C. At all temperatures, centres of the semicircles are below the real axis, i.e. depressed semicircles have been observed.

Total impedance of a polycrystalline has contributions of grain (g) and grain boundaries (gb) and sample/electrode interface (el). In impedance plots of the synthesized sample (in the temperature range of 300–650 °C), three arcs have been observed and their characteristics frequencies, ω_o ($\omega_o = 1/\rho\epsilon_o\epsilon_r$) differ significantly. The question of whether $\omega_{o,g}$, $\omega_{o,gb}$ and $\omega_{o,el}$ are significantly different from one another reduces to the question of whether or not the products $(\rho_g\epsilon_g)$, $(\rho_{gb}\epsilon_{gb})$ and $(\rho_{el}\epsilon_{el})$ differ significantly. While resistances of materials cover many orders of magnitude, dielectric constants do not vary that significantly. Thus, it is reasonable to make the assumption that $\epsilon_g \sim \epsilon_{gb} \sim \epsilon_{el}$ and the question reduces further to whether or not ρ_g , ρ_{gb} and ρ_{el} are significantly different from one another. A material in which $\sigma_g > \sigma_{gb} > \sigma_{el}$ (by definition $\rho_{el} > \rho_{gb} > \rho_g$), in turn implies that $\omega_{o,el} < \omega_{o,gb} < \omega_{o,g}$. Consequently, three arcs will be present in a complex plane impedance plot. The higher frequency arc is attributed to the grain (bulk) response and low frequency arc is attributed to electrode response and the semicircle between grain and electrode is attributed to the grain boundaries response. The resistance of each arc is given by

the distance across the real axis that each arc extends. In addition, the equivalent capacitance, C of each arc is given by $(R\omega_o)^{-1}$. The values of resistances and capacitances at different temperatures are calculated from manual fitting of the data and are given in table 3. It is already mentioned that in impedance plot of a polycrystalline material, separate arcs for grains and grain boundaries appear when the condition $\rho_{gb} > \rho_g$ is satisfied. If materials have typical microstructure, i.e. $g/G < 1$ (where G , average diameter of the grains and g , grain boundaries thickness), resistivity of grains and grain boundaries can be obtained by using the relations:

$$\rho_g = (A/L) \times R_g, \quad (6)$$

$$\rho_{gb} = (A/L) \times (G/g) \times R_{gb}, \quad (7)$$

where R_g and R_{gb} are resistances corresponding to high and intermediate frequencies arcs, respectively, and A , the cross-sectional area of the sample, L the sample length. Moreover, when the condition $\epsilon_g \sim \epsilon_{gb}$ is satisfied, then ratio of capacitance of high and intermediate frequencies arcs is $(C_g/C_{gb} = g/G)$ (Haile *et al* 1998).

The best manual fitting of the impedance data of sample at 350 °C yielded parameters: $R_g = 20500 \Omega$, $C_g = 2.2 \times 10^{-11} \text{ F}$, $R_{gb} = 18000 \Omega$ and $C_{gb} = 1.1 \times 10^{-9} \text{ F}$, geometric factor $A/L = 3.14 \text{ cm}$ and $C_g/C_{gb} = g/G = 2.0 \times 10^{-2}$. Resistivity of grains, $\rho_g = (A/L) \times (R_g) = 6.43 \times 10^4 \Omega\text{-cm}$, $\rho_{gb} = (A/L) \times (R_{gb}) \times (G/g) = 2.83 \times 10^6 \Omega\text{-cm}$ and $\rho_t = (A/L) \times (R_t) = 1.33 \times 10^5 \Omega\text{-cm}$. It is observed that though the resistance of grain boundaries is lower than the grain, resistivity of grain boundaries is two orders of magnitude

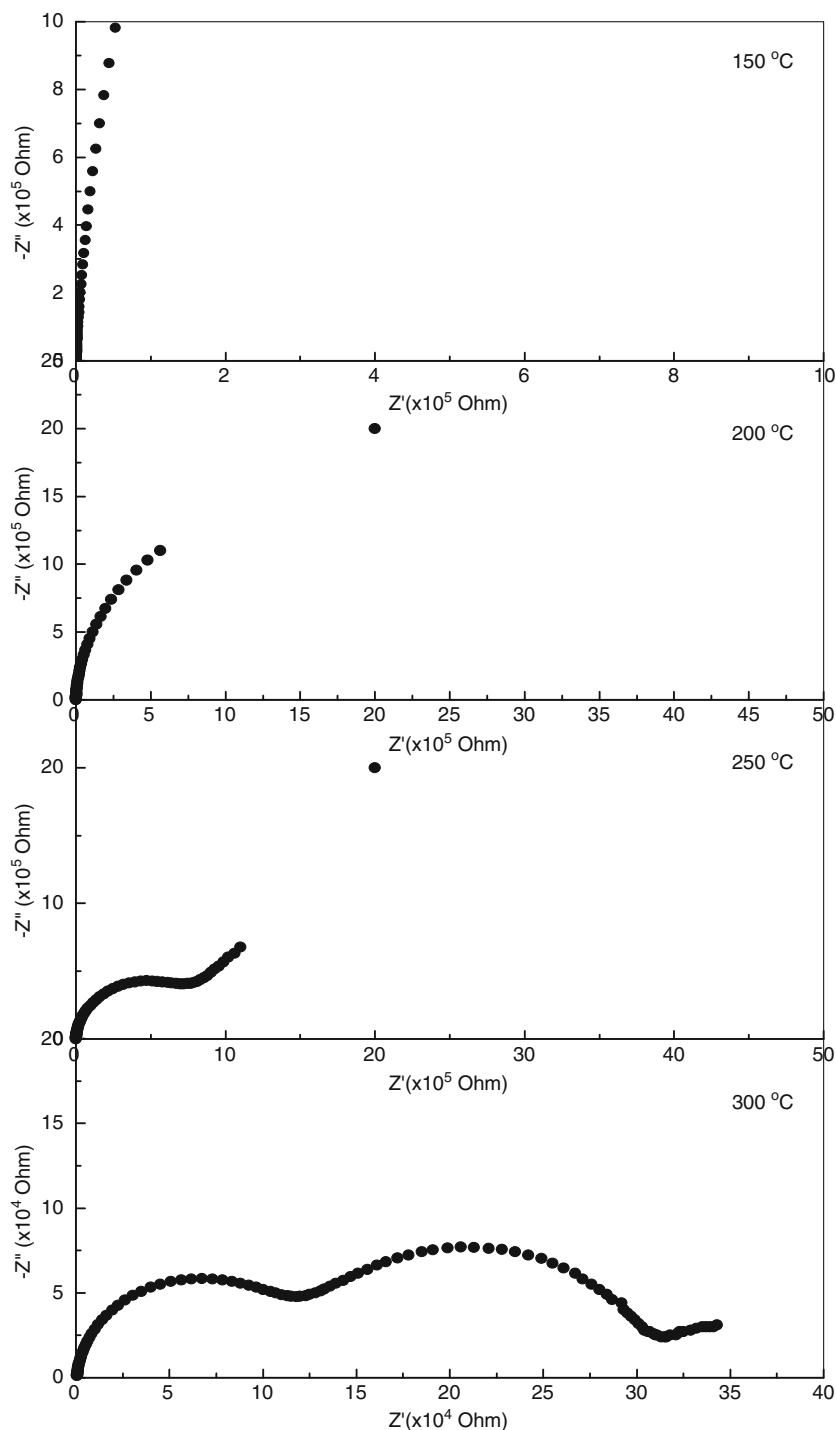


Figure 6. Complex plane impedance plots at few temperatures.

higher than that of the grains. Due to this fact, semicircular arcs for grains and grain boundaries are separated out in the impedance plots (figure 6).

Variation of logarithm of resistance of grains (R_g), grain boundaries (R_{gb}) and electrode (R_{el}) with inverse of temperature is shown in figure 7. Two linear regions with different slopes in two different temperature regions have been observed. These two temperature regions are denoted as

region I (300–450 °C) and region II (450–650 °C). Linear behaviour of resistances in both the temperature regions indicates that these resistances obey Arrhenius relation given by

$$R = R_0 \exp(E_a/k_b T), \quad (8)$$

where R_0 is pre-exponential factor, E_a the activation energy and k_b the Boltzmann's constant.

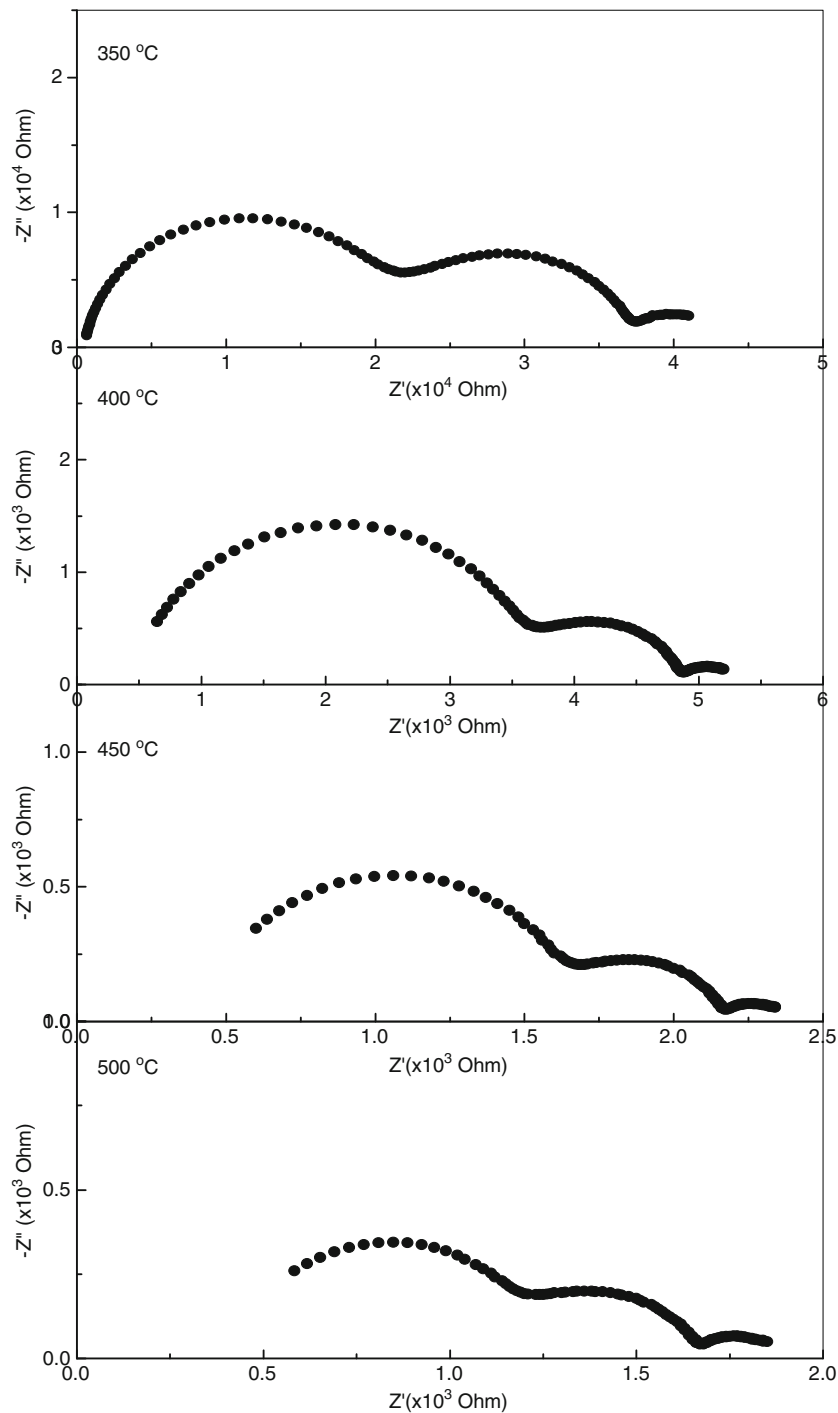


Figure 6. (Continued).

Activation energy in both the temperature regions are obtained by least square fitting of the data and are recorded in table 4. The value of activation energy in the low temperature region varies from 1.14 to 1.39 eV and in high temperature region from 0.37 to 0.51 eV.

The sample in the present study has been synthesized by solid state ceramic route at 1300 °C, therefore, there is a

possibility that oxygen leaves the lattice according to equation given below:



Therefore, the possibility of oxygen vacancies in the sample cannot be ruled out. It is reported that oxygen vacancies

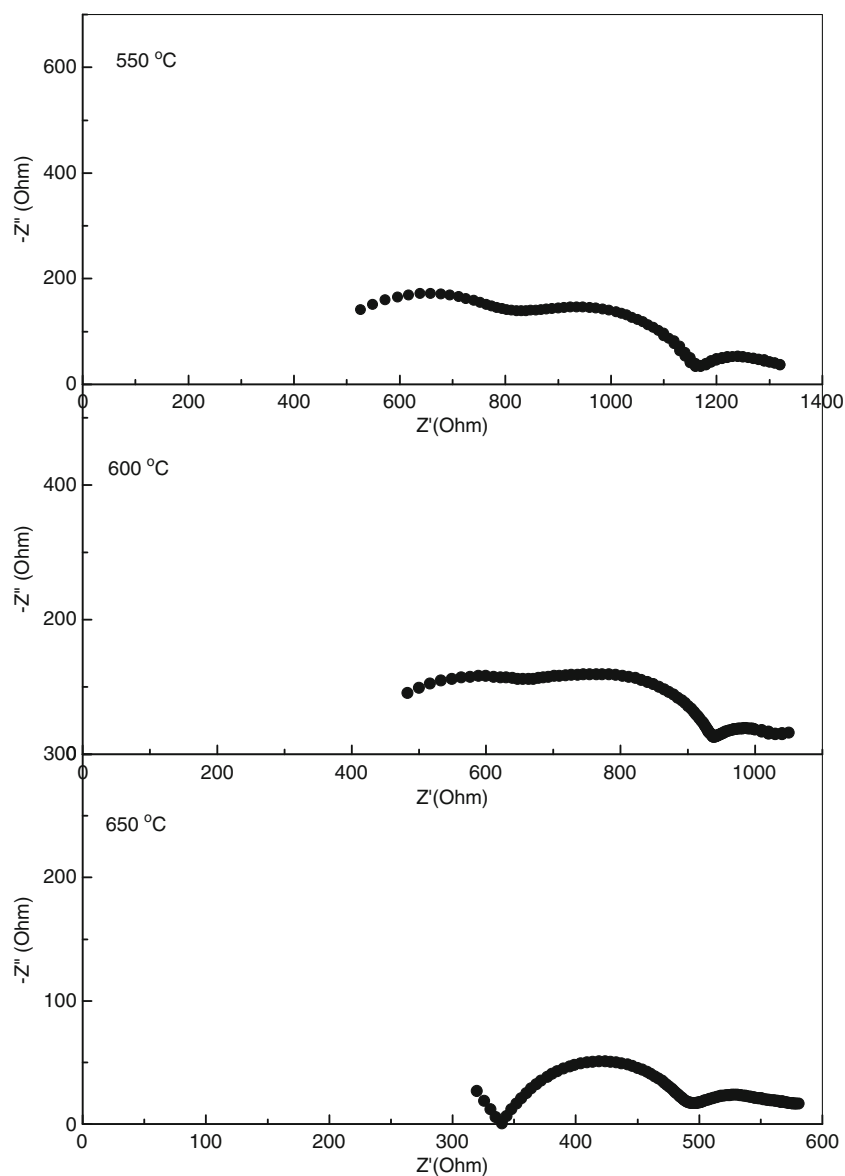


Figure 6. (Continued).

Table 3. Resistance and capacitance values obtained from complex plane impedance plots (figure 6) for BaSnO₃.

Temperature (°C)	Bulk (g)			Grain boundaries (gb)			Interfacial (el)		
	R_g (Ω)	f_g (kHz)	C_g (pF)	R_{gb} (Ω)	f_{gb} (kHz)	C_{gb} (nF)	R_{el} (Ω)	f_{el} (Hz)	C_{el} (μ F)
200	3.2×10^6	–	–	–	–	–	–	–	–
250	1.0×10^6	9	18	2.0×10^6	–	–	–	–	–
300	1.4×10^5	63	18	2.1×10^5	1.5	1	10×10^4	10	1
350	2.1×10^4	353	22	1.8×10^4	8.0	1	8.4×10^3	17	1
400	2.9×10^3	1995	28	1.5×10^3	36.0	3	6.5×10^2	50	5
450	1.2×10^3	3981	35	7.5×10^2	79.4	3	3.0×10^2	112	5
500	8.3×10^2	5012	38	5.0×10^2	305	1	2.5×10^2	223	3
550	3.8×10^2	5623	75	4.7×10^2	354	1	2.3×10^2	251	3
600	3.2×10^2	6012	84	3.4×10^2	501	1	1.6×10^2	398	3
650	–	–	–	1.6×10^2	891	1	1.0×10^2	512	3

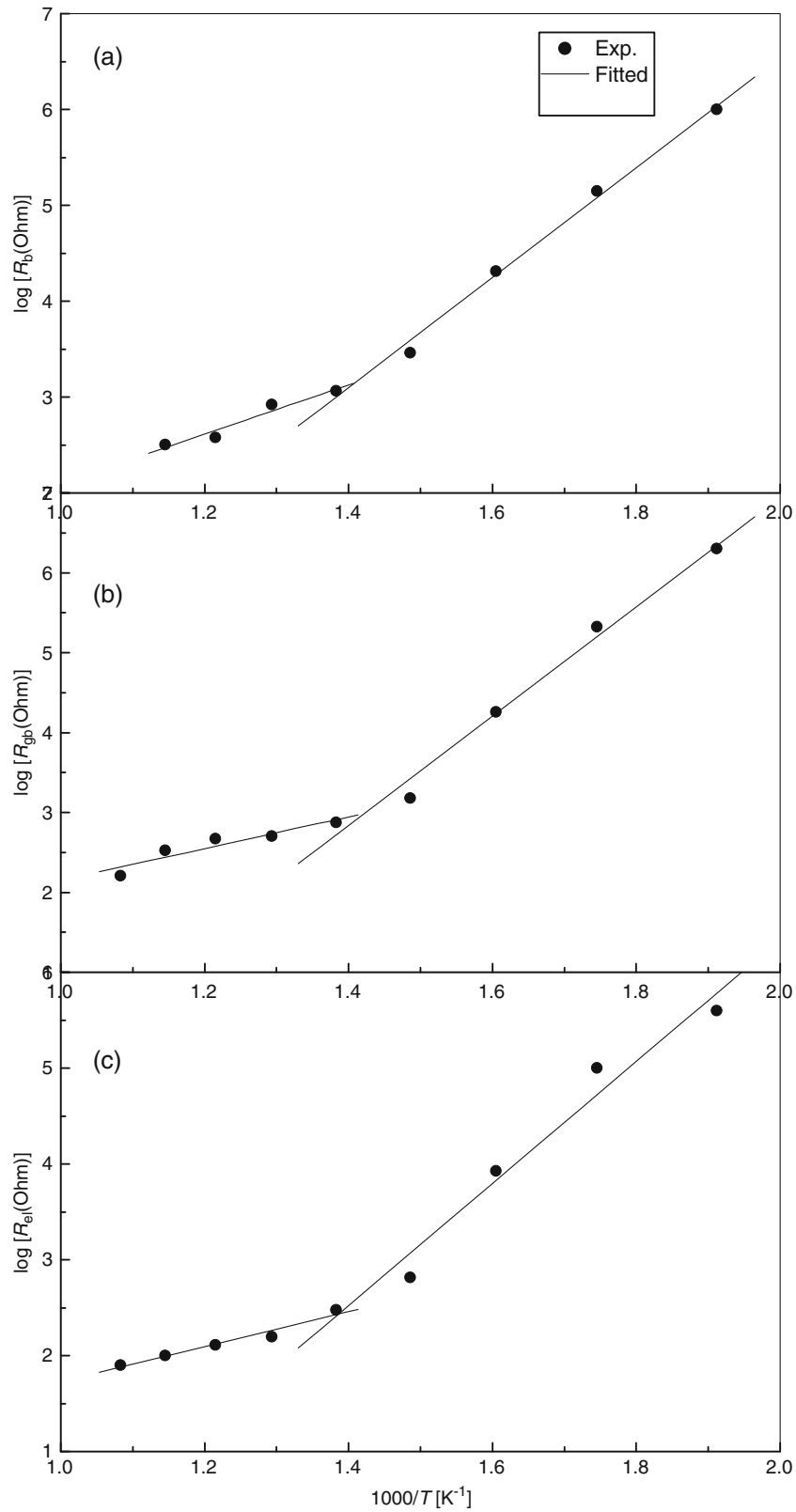


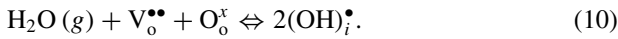
Figure 7. Variation of logarithm of resistance (obtained from figure 6) of (a) grain, (b) grain boundaries and (c) sample/electrode interface with inverse of temperature.

Table 4. Activation energy for conduction in grain (g), grain boundaries (gb) and electrode (el).

Temperature range (°C)	Activation energy (eV) obtained from									
	Figure 7			Figure 9			Figure 10			Figure 11
	R_g	R_{gb}	R_{el}	R_g	R_{gb}	R_{el}	τ_g	τ_{gb}	τ_{el}	ρ_t
300–500	1.14	1.36	1.26	1.14	1.39	1.32	1.04	0.87	0.52	1.23
500–650	0.51	0.37	0.38	0.51	0.41	0.42	–	0.87	0.52	0.51

(V_o^{••}) are highly mobile in perovskite structure and activation energy for diffusion of these vacancies is ~1 eV. Therefore, conduction in low temperature range (region I) is proposed to take place due to motion of doubly ionized oxygen vacancies (V_o^{••}) (Murugaraj *et al* 1997; Lu *et al* 2000).

This sample has a porosity of ~20%, hence, if electrical properties are measured in a humid atmosphere, H₂O molecules can be adsorbed on the surface of the material. As mentioned above, this material has sufficient amount of oxygen vacancies (V_o^{••}) and lattice oxygen (O_o^x) which leads to the formation of an interstitial proton (OH)_i[•] associating with neighbouring O_o^x according to the following equation:



The interstitial proton (OH)_i[•] may hop around the oxygen vacancies, V_o^{••}. In the literature, activation energy for proton conduction in perovskite materials is reported to be between 0.40 and 0.50 eV. Activation energy in the high temperature range (region II) of the sample lies between 0.39 and 0.52 eV (Kreuer 1999, 2003). Hence, it is proposed that conduction in the high temperature range (region II) is due to migration of protonic defect. Similar activation energy of all the three resistances shows that sufficient amount of protons (OH)_i[•] are present in the bulk (grain) of the material, i.e. adsorption of water molecule is not limited to the surface, but has penetrated through grains. It is worthwhile to mention that in the synthesis of this sample, water has not been used at any stage.

It is reported in the literature that electrical properties and impedance behaviour of a ceramic oxide is a phase-sensitive parameter. Appearance of more than one semicircle in complex plane impedance plots (in figure 6) may be due to presence of another (second) phase (Macdonald 1987). However, in the present study, variation of resistances of all the three contributions is similar. The three resistances, R_g , R_{gb} and R_{el} follow exactly similar behaviour with almost same activation energy in both the temperature regions. This suggests that the conduction species (phases) responsible for all the three regions are similar. Due to difference in the resistivity of grain and grain boundaries, ionic charge carriers may deplete and accumulate at the interface of grain and grain boundaries. Development of space charge region increases as the size of grain decreases. A brick layer model of grain boundaries with space charge effect, i.e. total width of grain boundaries is divided into two parts, grain boundaries core (*gbc*) and space charge zone (*scz*). Thus, a polycrystalline material can have three electrically different regions viz. grain (*g*), space charge zone (*scz*) and grain

boundaries core (*gbc*) (Park *et al* 2009). Similar conduction behaviour of the three resistances corresponding to the three semicircles in figure 6 indicates that the third semicircle (in lowest frequency range) may be due to the presence of interface at grain–grain boundaries rather than sample–electrode interface.

Figure 8 shows variation of real part of impedance (Z') as a function of frequency at three different temperatures. Similar behaviour is observed at higher temperatures also. Presence of three relaxation processes is clearly seen in these plots. It is also clear that relaxation time of these processes is temperature-dependent. The trend of impedance vs frequency plot provides an indication of increasing conduction with frequency and temperature (i.e. negative temperature coefficient (NTC) of resistance behaviour typical of semiconductors). Total impedance at 10 Hz frequency (since 10 Hz frequency data is very much close to d.c. value) at different temperatures is obtained from figure 8. Using these data, total d.c. resistivity of the sample is calculated at different temperatures, to attain a maximum value of $3.2 \times 10^3 \Omega\text{-cm}$ at 650 °C. This is a very low resistivity when compared with a resistivity of $1.3 \times 10^9 \Omega\text{-cm}$ at 150 °C, indicating a jump of nearly six orders of magnitude. The variation of logarithm of total resistivity, ρ_t , with inverse of temperature is shown in figure 9. Two linear regions (with respect to temperature) with different slopes have been observed. These two temperature regions are the same as in figure 7. Linear behaviour of resistivity in both the temperature regions indicates that the total resistivity also obeys Arrhenius relation given by

$$\rho = \rho_0 \exp(E_a/k_b T) \quad (11)$$

Activation energy in both the temperature regions is obtained by least square fitting of the data and recorded in table 4. The value of activation energy in the low temperature range is 1.14 eV, whereas in high temperature range, it is 0.37 eV. This observation supports that overall conduction in the low temperature region (300–450 °C) is due to motion of doubly ionized oxygen vacancies (V_o^{••}), whereas in higher temperature range (450–600 °C) it occurs due to migration of protonic defect (OH)_i[•].

Variation of Z'' with logarithm of frequency at different temperatures is shown in figure 10. It is observed that at and above 300 °C, three peaks are present in these plots. Position of each peak shifts towards higher frequency side with increasing temperature. The heights of these peaks decrease with increase in temperature. A typical peak broadening

which is slightly asymmetrical in nature can also be observed with rise in temperature. Broadening in low frequency and intermediate frequency peaks is more than broadening in high frequency peak. Moreover, broadening in peak is independent of temperature. This suggests that there is a spread of relaxation time, i.e. the temperature-dependent electrical

relaxation phenomenon exists in the material. However, for samples in the present system, FWHM is >1.144 decades for all the three peaks, which is attributed to the distribution of relaxation time.

Resistances of grain, grain boundaries and electrode have been obtained by manually fitting of data as shown in

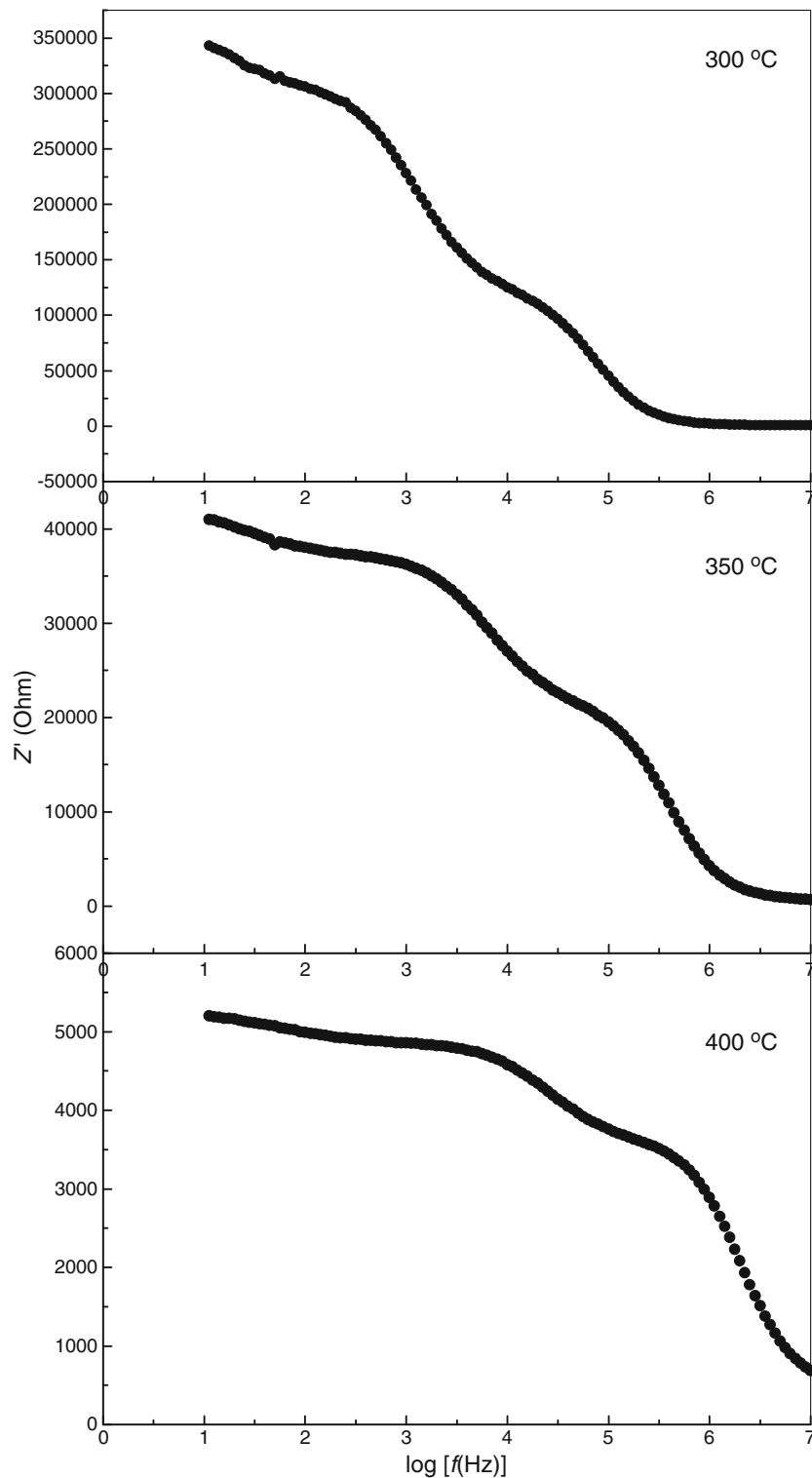


Figure 8. Variation of Z' with logarithm of frequency at three different temperatures.

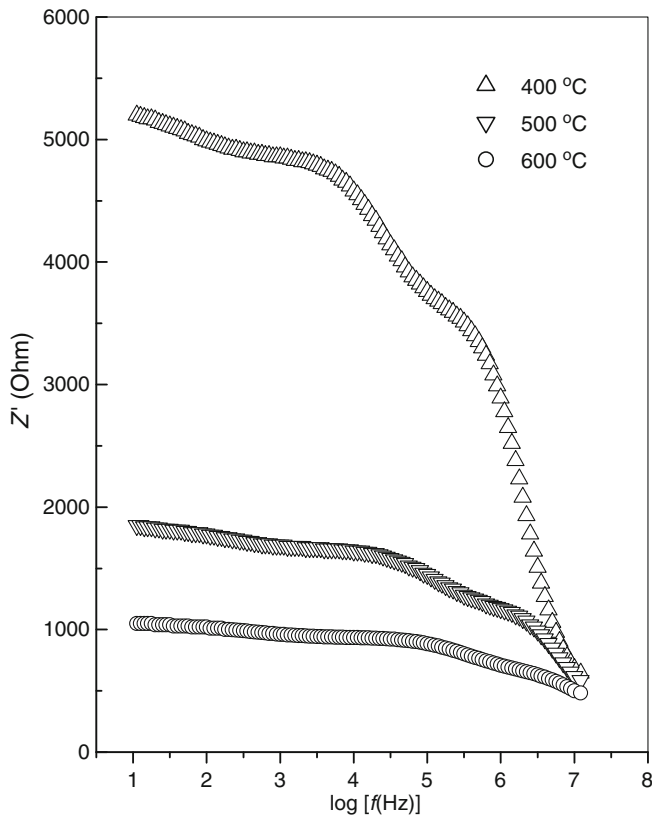


Figure 8. (Continued).

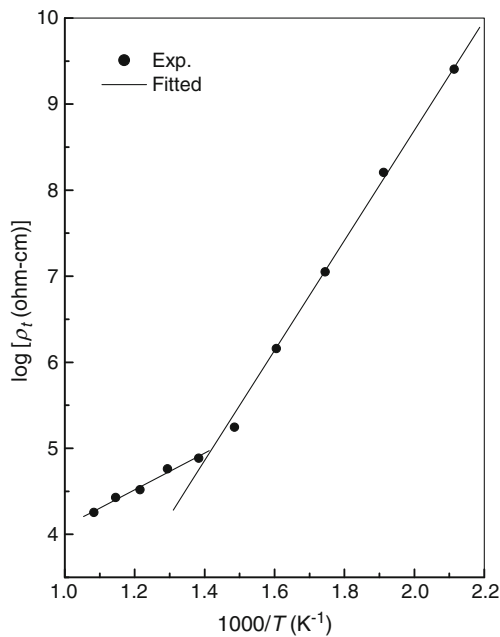


Figure 9. Variation of logarithm of total resistivity with inverse of temperature.

figure 6. Therefore, there is a possibility of error which may lead to an error in determination of activation energy and hence the interpretation in conduction mechanism. A peak is

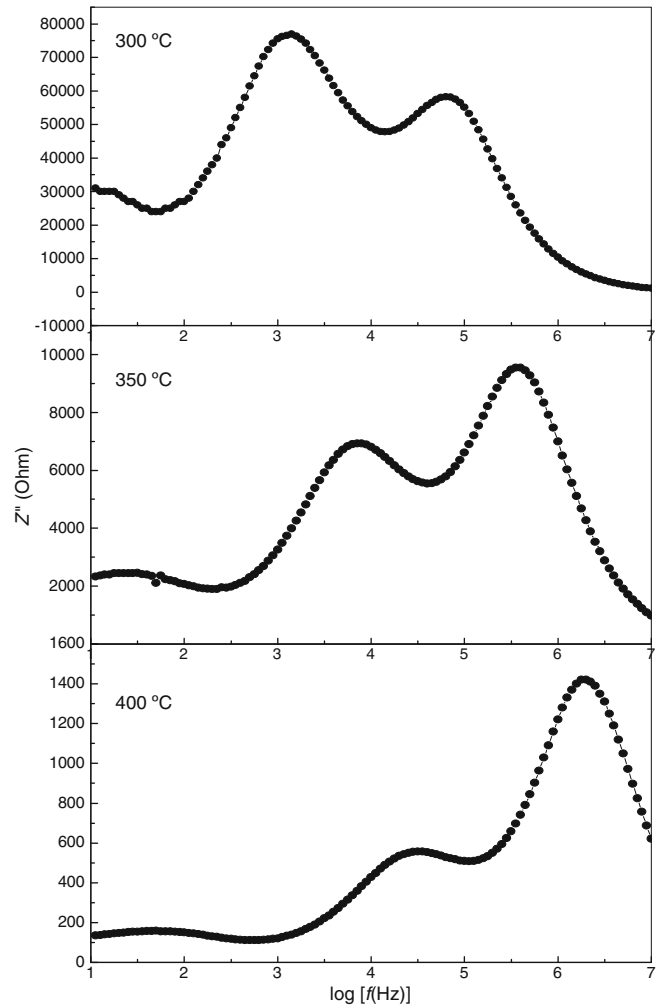


Figure 10. Variation of Z'' with logarithm of frequency at a few temperatures.

observed in Z'' vs $\log f$ plots when the relation $\omega\tau = 1$ is satisfied (ω – angular frequency is equal to $2\pi f$, f being the frequency (Hz) and τ the relaxation time). It is clear from (2) that height of peak in Z'' vs $\log f$ plots (figure 10) for lower, intermediate and higher frequencies is $R_g/2$, $R_{gb}/2$ and $R_{el}/2$, respectively. Using this fact once again, values of resistances of grain (g), grain boundaries (gb) and electrode (el) have been calculated and given in table 5; the corresponding frequencies and capacitances are also given. Variation of resistances with inverse of temperature is shown in figure 11. Activation energies obtained from this plot are given in table 4. The value of activation energy estimated from figure 11 (in both the temperature regions) when compared with activation energy value obtained from figure 7, is observed to have approximately the same value, well within experimental error. This result possibly provides an indication that interpretation in the conduction mechanism is not affected by obtaining resistance value by manual fitting of the data in figure 6.

Relaxation frequency and hence relaxation time (τ) is a parameter that depends only on the intrinsic properties of

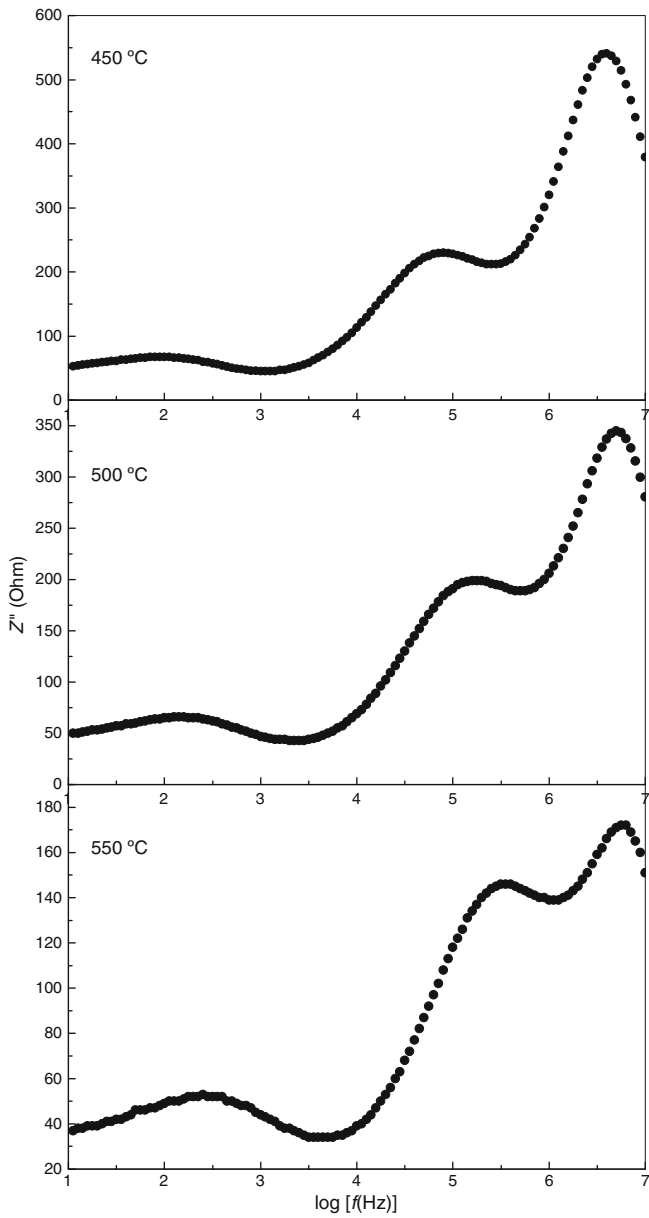


Figure 10. (Continued).

materials and not on the sample's geometrical features. The term 'intrinsic properties' of the material refers to the properties attributed to the structural/microstructural, i.e. grain interior or bulk. These properties govern the distribution of resistance and capacitance ultimately depends on relaxation. So, the results obtained using impedance analysis are basically unambiguous and provide a time picture of the sample electrical behaviour.

In figure 10, the position of peaks shifts towards higher frequency side with increasing temperature. A peak is observed when the relation $\omega\tau = 1$ is satisfied (ω – angular frequency is equal to $2\pi f$, f being the frequency (Hz) and τ ,

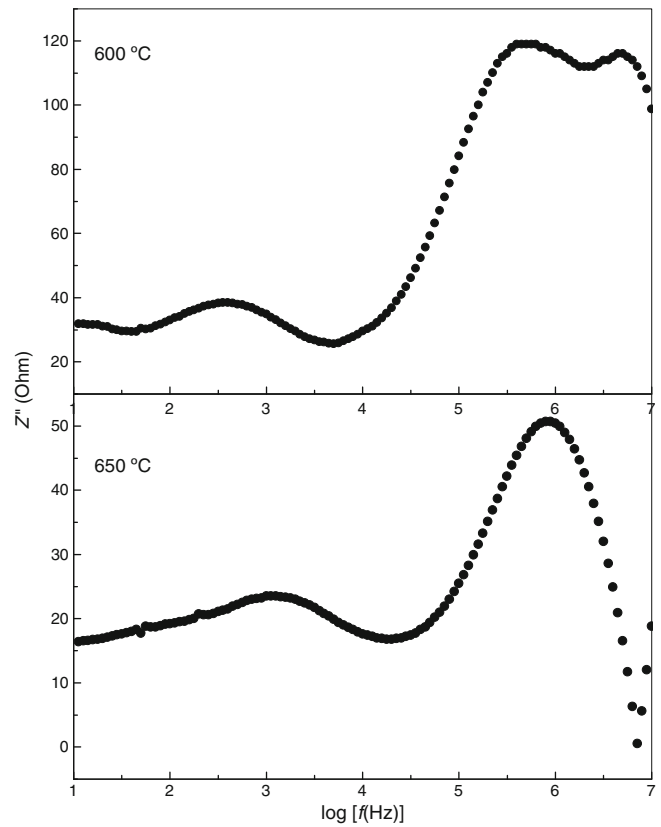


Figure 10. (Continued).

Table 5. Resistance and capacitance values obtained from Z'' vs $\log f$ plots (figure 10) for BaSnO₃.

Temperature (°C)	Bulk (g)			Grain boundaries (gb)			Interfacial (el)		
	R_g (Ω)	f_g (kHz)	C_g (pF)	R_{gb} (Ω)	f_{gb} (kHz)	C_{gb} (nF)	R_{el} (Ω)	f_{el} (Hz)	C_{el} (μF)
300	12×10^4	63	22	16×10^4	1.5	1	9.0×10^4	10	1
350	2.0×10^4	353	24	1.4×10^4	8.0	1	5.4×10^3	17	2
400	2.9×10^3	1995	28	1.2×10^3	36.0	4	4.0×10^2	50	8
450	1.10×10^3	3981	37	5.8×10^2	79.4	4	1.5×10^2	112	9
500	7.0×10^2	5012	46	4.6×10^2	305	1	1.2×10^2	223	6
550	3.4×10^2	5623	84	3.7×10^2	354	1	1.1×10^2	251	6
600	3.0×10^2	6012	88	2.4×10^2	501	1	7.0×10^1	398	6
650	–	–	–	1.4×10^2	891	2	5.0×10^1	512	3

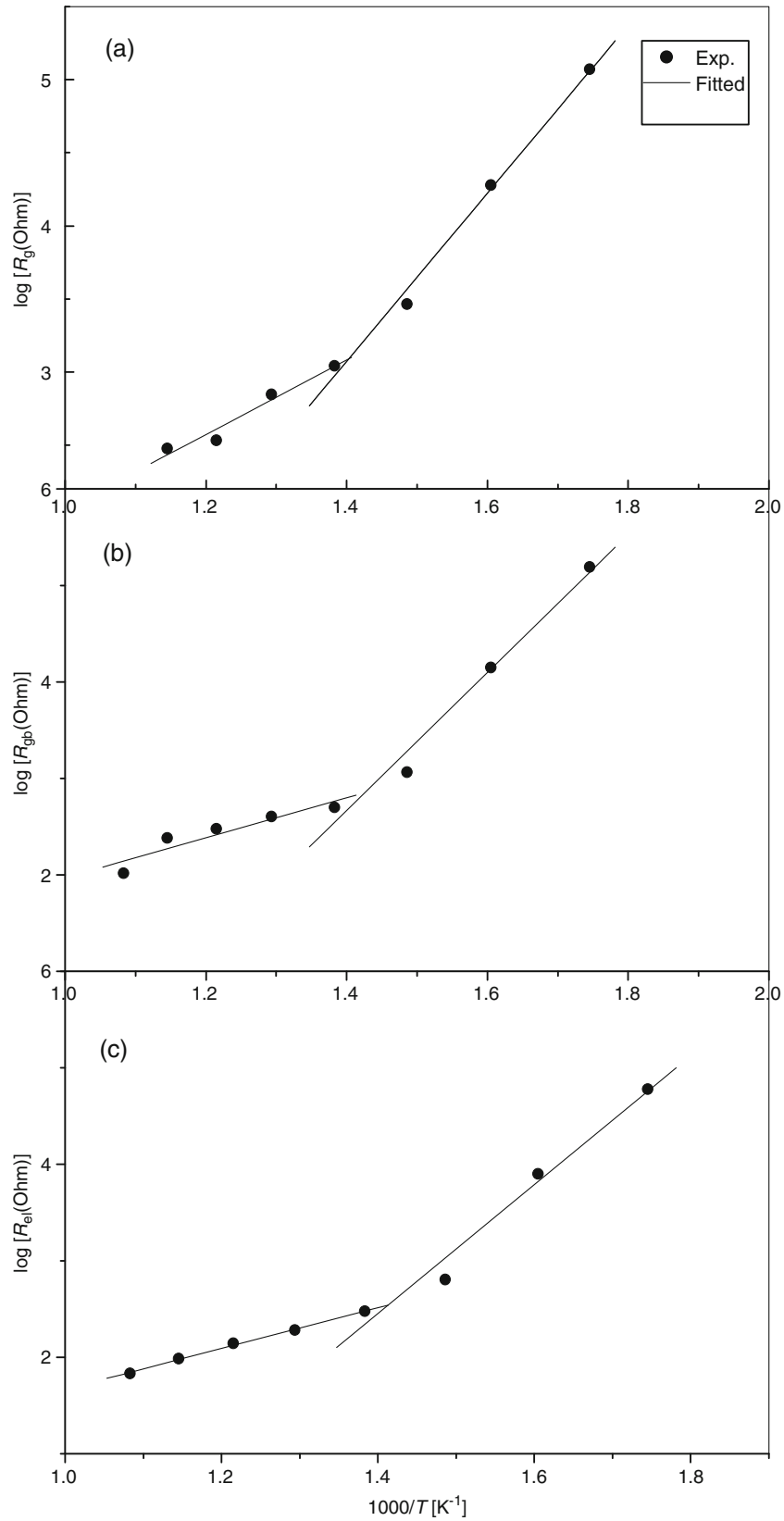


Figure 11. Variation of logarithm of resistance (obtained from figure 10) of (a) grain, (b) grain boundaries and (c) sample–electrode interface with inverse of temperature.

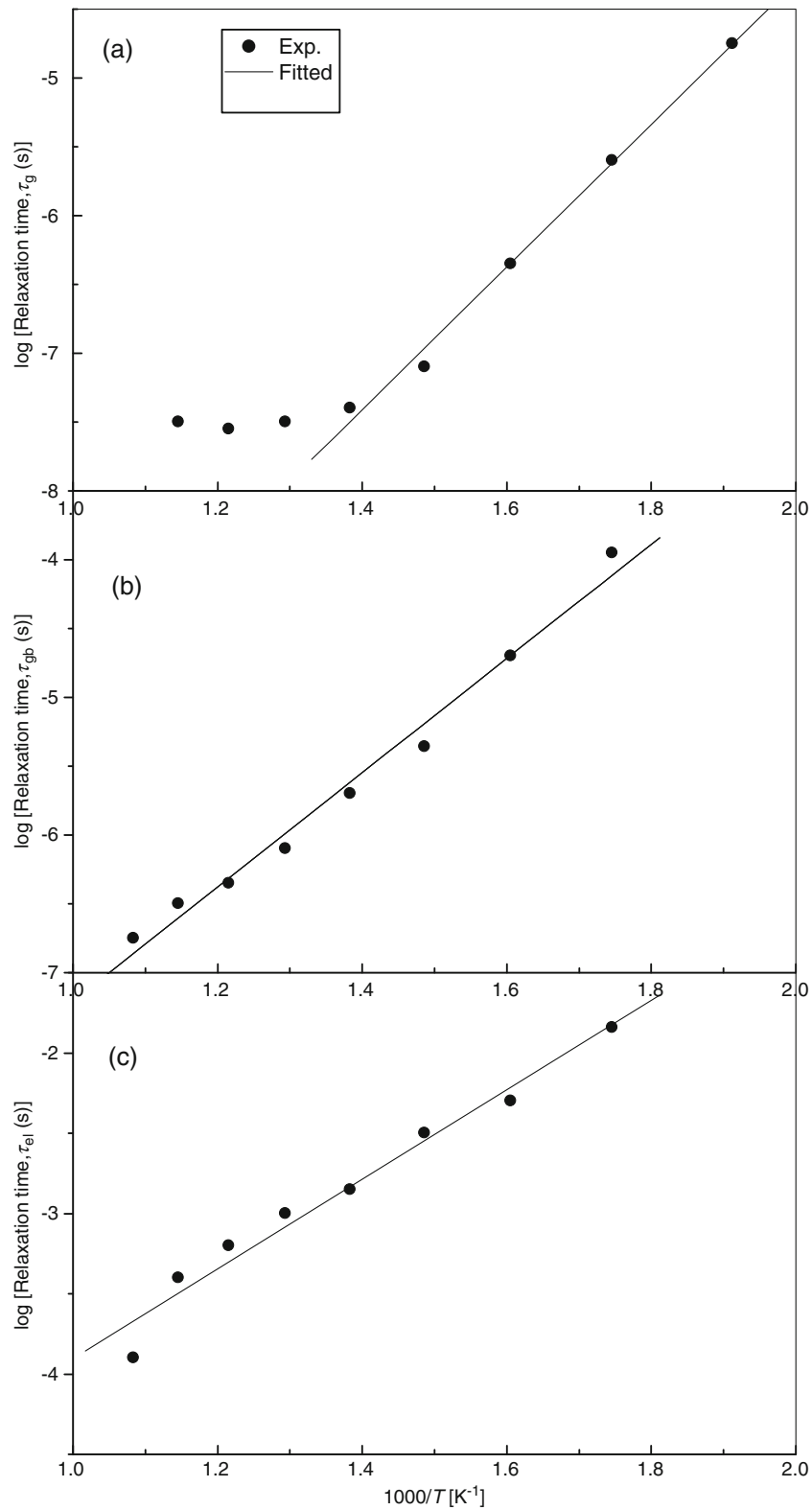


Figure 12. Variation of logarithm of relaxation time (obtained from figure 10) of (a) grain, (b) grain boundaries and (c) sample–electrode interface with inverse of temperature.

the relaxation time). With increase in temperature, the relation $\omega\tau = 1$ is satisfied at higher frequency. The relaxation time τ for grain, grain boundaries and interface is determined from peak position and plots of $\log \tau$ (relaxation time) with the inverse of temperature for all the three contributions are shown in figure 12. Variation of $\log \tau_g$, τ_{gb} and τ_{el} with the inverse of temperature shows single linear region in entire range of temperatures. Linear behaviour of $\log \tau$ with $1000/T$ indicates that relaxation time obeys Arrhenius relation given by

$$\tau = \tau_0 \exp(E_\tau/k_B T), \quad (12)$$

where τ_0 is the relaxation time at infinite temperature, E_τ the activation energy for relaxation, k_B the Boltzmann's constant and T the absolute temperature. A linear fit of $\log \tau$ vs $1000/T$ plots has been used to estimate the activation energy of the material. The values so obtained are recorded in table 4. This value of activation energy (E_τ) estimated for grains at low temperature (≤ 450 °C) when compared with activation energy value (E_a) is observed to have approximately the same value, well within experimental error. This result possibly provides an indication that electrical species (charge carriers) involved in the process of relaxation and conduction for the grains in low temperature range are the same. The value of activation energy of grain boundaries and electrode for relaxation (E_τ) when compared with the activation energy for conduction (E_a) values shows marked differences. This result possibly provides an indication that electrical species (charge carriers) involved in the process of relaxation and conduction are different.

4. Conclusions

Powder XRD studies of BaSnO₃ confirm the formation of single phase cubic structure. Scanning electron microscopy has confirmed the polycrystalline texture of the material with porous microstructure. EDX analysis confirmed the homogeneous nature of the synthesized material. TGA curve of the sample exhibited adsorption of water molecules by the synthesized powder. Presence of protonic defects has been supported by FTIR spectrum of the sample. The a.c. impedance analysis reveals that at higher temperatures, total impedance is the contribution of grain, grain boundaries and electrode. Two temperature ranges with different activation energies have been observed for all the three resistances. Activation energies in both the temperature ranges for the three resistances match well. Therefore, it is concluded that conduction species (phases) responsible for conduction within grain, grain boundaries and electrode are the same. Activation energy estimated from the variation of resistances/total resistivity confirmed that conduction in low temperature region (300–450 °C) is due to thermal diffusion of doubly ionized oxygen vacancies ($V_O^{\bullet\bullet}$), whereas in the high temperature region (450–650 °C), it occurs due to hopping of $(OH)^\bullet$ ions.

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